Vishay Siliconix

P-Channel 30 V (D-S) MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	-30			
$R_{DS(on)}$ max. (Ω) at V_{GS} = -10 V	0.0073			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -4.5 \text{ V}$	0.0130			
Q _g typ. (nC)	28			
I _D (A)	-65.7			
Configuration	Single			

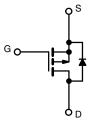
FEATURES

- TrenchFET® Gen IV p-channel power MOSFET
- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



APPLICATIONS

- Adapter switch
- · Load switch
- Motor drive control
- Battery management
- Motor drive control



P-Channel MOSFET

ORDERING INFORMATION	
Package	PowerPAK SO-8
Lead (Pb)-free and halogen-free	SIR1309DP-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	-30	V	
Gate-source voltage		V _{GS}	± 25	v	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		-65.7		
	T _C = 70 °C	1 . —	-52.6		
	T _A = 25 °C	I _D	-19.1 ^{a, b}		
	T _A = 70 °C		-15.3 ^{a, b}	^	
Pulsed drain current (t = 100 µs)		I _{DM}	-150	A	
Continuous source-drain diode current	T _C = 25 °C		-51.6		
	T _A = 25 °C	I _S	-4.3 ^{a, b}		
Single pulse avalanche current	L = 0.1 mH	I _{AS}	-20		
Single pulse avalanche energy	L = U. I IIII	E _{AS}	20	mJ	
Maximum power dissipation	T _C = 25 °C		56.8		
	T _C = 70 °C		36.3	14/	
	T _A = 25 °C	P _D	4.8 ^{a, b}	W	
	T _A = 70 °C		3.0 ^{a, b}		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	90	
Soldering recommendations (peak temperature) c, d			260	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient a, e	t ≤ 10 s	R _{thJA}	22	26	°C/W	
Maximum junction-to-case (drain)	Steady state	R_{thJC}	1.8	2.2	- C/VV	

Notes

- a. Surface mounted on 1" x 1" FR4 board
- b. t = 10 s
- c. See solder profile (www.vishay.com/doc?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- d. Rework conditions: Manual soldering with a soldering iron is not recommended for leadless components
- e. Maximum under steady state conditions is 70 °C/W

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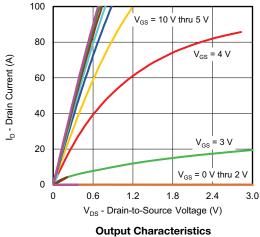
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			•	•	•	•	
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-30	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = -250 μA	-	-27	-	m\//°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = -250 μA	-	4.4	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1	-	-2.5	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$	-	-	100	nA	
Zero gate voltage drain current	I _{DSS}	V _{DS} = -30 V, V _{GS} = 0 V	-	-	-1		
		V _{DS} = -30 V, V _{GS} = 0 V, T _J = 70 °C	-	-	-15	μA	
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-40	-	-	Α	
Drain-source on-state resistance ^a	_	V _{GS} = -10 V, I _D = -10 A	-	0.006	0.0073	Ω	
	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -10 \text{ A}$	-	0.0102	0.0130		
Forward transconductance ^a	9 _{fs}	$V_{DS} = -10 \text{ V}, I_{D} = -10 \text{ A}$	-	37	-	S	
Dynamic ^b							
Input capacitance	C _{iss}	V _{DS} = -15 V, V _{GS} = 0 V, f = 1 MHz	-	3250	-	pF	
Output capacitance	C _{oss}		-	410	-		
Reverse transfer capacitance	C _{rss}		-	375	-		
Tatal asta shaves	0	V _{DS} = -15 V, V _{GS} = -10 V, I _D = -10 A	-	58	87	nC	
Total gate charge	Q_g		-	28	8 42		
Gate-source charge	Q _{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -10 \text{ A}$	-	10.7	-		
Gate-drain charge	Q _{gd}		-	9.9	-		
Gate resistance	R _g	f = 1 MHz	1.1	2.2	3.8	Ω	
Turn-on delay time	t _{d(on)}	$V_{DD} = -15 \text{ V}, R_L = 1.5 \Omega, I_D \cong -10 \text{ A},$	-	12	24		
Rise time	t _r		-	7	14		
Turn-off delay time	t _{d(off)}	$V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$	-	40	80		
Fall time	t _f		-	8	16		
Turn-on delay time	t _{d(on)}		-	26	54	ns	
Rise time	t _r	V_{DD} = -15 V, R_L = 1.5 Ω , I_D \cong -10 A, V_{GEN} = -4.5 V, R_g = 1 Ω	-	67	135	-	
Turn-off delay time	t _{d(off)}		-	30	60		
Fall time	t _f		-	20	40		
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	-51.6	_	
Pulse diode forward current	I _{SM}		-	-	-150	A	
Body diode voltage	V_{SD}	$I_S = -5 \text{ A}, V_{GS} = 0 \text{ V}$	-	-0.75	-1.1	V	
Body diode reverse recovery time	t _{rr}		-	18	36	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = -10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	8	16	nC	
Reverse recovery fall time	ta	T _J = 25 °C	-	9	-		
Reverse recovery rise time	t _b		-	9	_	ns	

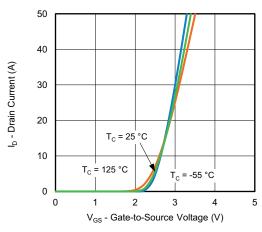
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

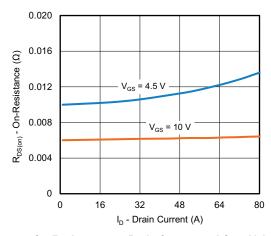
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

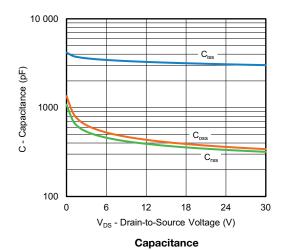




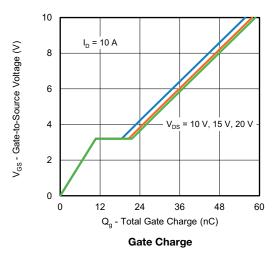


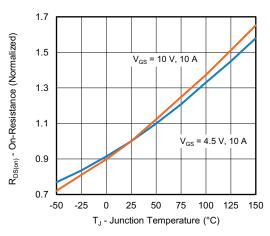






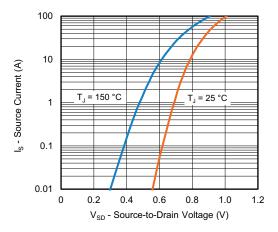
On-Resistance vs. Drain Current and Gate Voltage



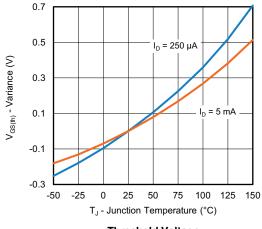


On-Resistance vs. Junction Temperature

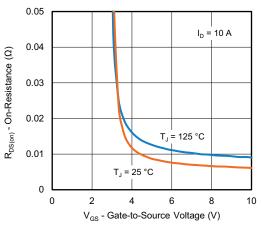




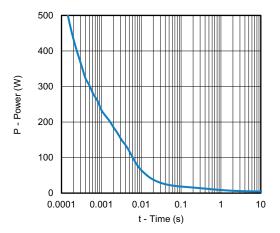
Source-Drain Diode Forward Voltage



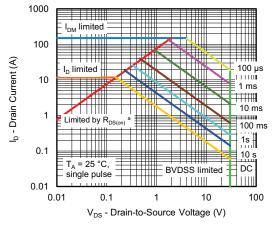
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

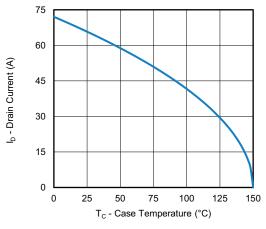


Single Pulse Power, Junction-to-Ambient

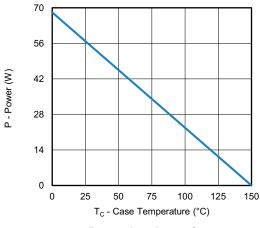


Safe Operating Area, Junction-to-Ambient

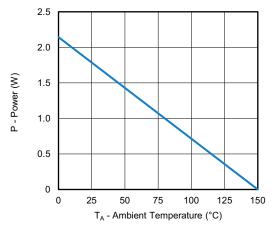




Current Derating a



Power, Junction-to-Case

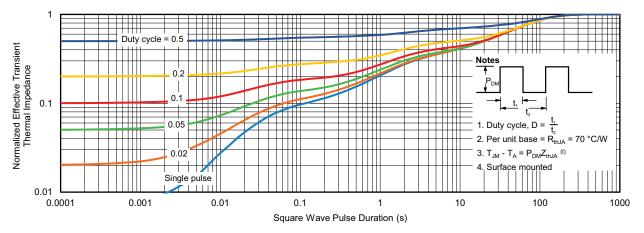


Power, Junction-to-Ambient

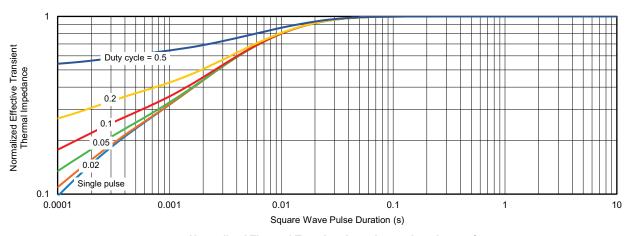
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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